

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10630984	KAKUMOTO ET AL.
	Examiner Henn, Timothy J	Art Unit 2622

SEARCHED

Class	Subclass	Date	Examiner
348	241,243,245,296,301,308	10/28/06	TJH
348	300	6/22/07	TJH

SEARCH NOTES

Search Notes	Date	Examiner
Updated Search	6/22/07	TJH
Consulted Vivek Srivastava -> see Lin Ye, NgocYen Vu	6/22/07	TJH
Consulted NgocYen Vu	6/22/07	TJH
Consulted Lin Ye -> Correlated Double Sampling (CDS), Tapered Reset	6/22/07	TJH
Consulted Vivek Srivastava Re: CDS and reset voltages	6/22/07	TJH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
348	301,308	6/22/07	TJH